## Application/Control No. Applicant(s)/Patent Under Reexamination 10/733,927 JEONG ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Khawar Iqbal 2617 **U.S. PATENT DOCUMENTS** Document Number Date Classification Country Code-Number-Kind Code Name MM-YYYY 07-2004 455/500 US-2004/0127240 A1 Li, Sheung Α \* 09-2004 370/474 US-2004/0179549 A1 Ophir et al. В \* 10-2004 455/161.1 US-2004/0214539 A1 Rajamani et al. С US-D Ε US-F US-G US-US-Н US-1 US-J US-K US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

W

Х